

**Notice of References Cited**

Application/Control No.

10/536,462

Applicant(s)/Patent Under  
Reexamination  
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Examiner

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Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0039874	02-2003	Jankowski et al.	429/26
*	B	US-2002/0076586	06-2002	Tanaka, Koichi	429/19
	C	US-			
	D	US-			
	E	US-			
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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